## INFORMATION DISCLOSURE STATEMENT

**Applicants** 

Liu, et al.

App. No.

Unknown

Filed

: Herewith

For

PASSIVATED MAGNETO-RESISTIVE

BIT STRUCTURE AND PASSIVATION

**METHOD THEREFOR** 

Examiner

Unknown

Group Art Unit

Unknown

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## Dear Sir:

Enclosed are copies of forms PTO-1449 and 892 listing 42 references. These references are of record on related application No. 10/057,162, filed January 24, 2002. Therefore, copies of the references are not enclosed. This Information Disclosure Statement is being submitted upon filing, and no fee is required in accordance with 37 C.F.R. § 1.97(b)(1).

Identification herein is not an admission that any of the foregoing references are prior art to the above-captioned application.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: Hugust 22, 2003

Michael S. Okamoto

Registration No. 47,831

Attorney of Record

Customer No. 20,995

(310) 551-3450

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.





SHEET 1 OF 2

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
MICRON. 214001

APPLICATION NO. 10/057,182
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(USE SEVERAL SHEETS IF NECESSARY)

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APPLICANT Liu et al.

FILING DATE January 24, 2002 Herewith

GROUP Unknown

			U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
	3,623,032	11/23/71	Schapira			
	3,623,035	11/23/71	Kobayashi et al.			
	3,816,909	6/18/74	Maeda et al.			
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EXAMINER

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\*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.



SHEET 2 OF 2

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. MICRON.214BV1 2(4 DDU) APPLICATION NO. <del>10/057,</del>162 Un known

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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FILING DATE January 24, 2002 HereWTh

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	6,048,739	4/11/00	Hurst et al.						

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INITIAL						YES	NO	
	DE 198 36 567 A 1	2/24/00	Germany					
	WO 00/19440	4/6/00	PCT			•		
	EP 0 776 011 A2	5/28/97	EPO					
	WO 98/20496	5/14/98	EPO					
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	Honeywell Brochure entitled Pohm et al., "The Architecture of a High Performance Mass Store with GMR Memory Cells," Nonvolatile Electronics, pp. 1-3.						
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